

Search Notes

Application/Control No.

10/521,521

Examiner

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Applicant(s)/Patent under
Reexamination

TRIOANO ET AL.

Art Unit

2681

SEARCHED

Class	Subclass	Date	Examiner
455	412.1 412.2	12/15/05	DR
	414.1		
	432.3		
	41.2		
205	25		
209	23		
213	85	12/15/05	DR
240	5.82		
379	142		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search	12/15/05	DR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner